


<b>Search Notes</b>  	<b>Application/Control No.</b>  10782231	<b>Applicant(s)/Patent Under Reexamination</b>  MOELLER ET AL.
	<b>Examiner</b>  Kim, David S	<b>Art Unit</b>  2613

### SEARCHED

Class	Subclass	Date	Examiner
398	155,202	9-1-09	lp

### SEARCH NOTES

Search Notes	Date	Examiner
reviewed references in U.S. Patent Application No. 10/730,413	12/22/2006	DSK
EAST search - see search history printout	12/22/2006	DSK
www.google.com - search terms: or gate nand	12/22/2006	DSK
EAST search - see search history printout	10/15/2007	DSK
www.google.com - various combinations of the following terms: NRZ pulse broadening widens dispersion eye diagram -spm	10/15/2007	DSK
scholar.google.com - various combinations of the following terms: NRZ pulse broadening widens broaden widen	10/15/2007	DSK
EAST search - see search history printout	12/19, 12/20/2008	DSK
www.google.com - various combinations of the following terms: duobinary waveform NRZ RZ "sampling window" "sampling point"	12/19, 12/20/2008	DSK
scholar.google.com - various combinations of the following terms: duobinary duty cycle 100 NRZ waveform RZ "sampling window" "sampling point" eye integrating window diagram narrow integration sampling	12/19, 12/20/2008	DSK

### INTERFERENCE SEARCH

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398	155,202	9-1-09	lp

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